

SSY011 - ELECTRICAL SYSTEMS

Laboratory Report

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CHALMERS

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Summary

This laboratory report presents the design, construction, testing and verification of a digital audio transfer system. The system is composed of a transmitter and a receiver, which are themselves composed of a number of subsystems. The chief component of the system was an FPGA, which primarily was used to serve as a digital control unit. The design is modular and each individual subsystem is presented in detail in this report.

The system succeeded in its primary goal of transmitting and receiving audio using the RS-232 protocol, though failed to meet all of the set specifications, especially the bandwidth criteria, which was far below the expected range. Despite this, the system was eminently usable for transmitting speech.

1 Introduction

The goal of this laboratory assignment is to design, construct, test and characterize a digital audio transmission system. The system as a whole consists of many different component subsystems, as summarized in the block diagram in figure 1.

The design revolves around the use of the Altera DE1 development board and the FPGA (Field Programmable Gate Array) it houses. The FPGA is programmed using VHDL (*Very High Speed Integrated Circuit Hardware Description Language*) in order to generate timings, to implement combinational and sequential gate-level logic and especially in order to construct finite-state machines as will be discussed later on in this report. The remaining electrical subsystems are constructed using discrete components on a prototyping breadboard. The frequencies in this system are low enough that the use of a prototyping board should result in any expected behaviour.

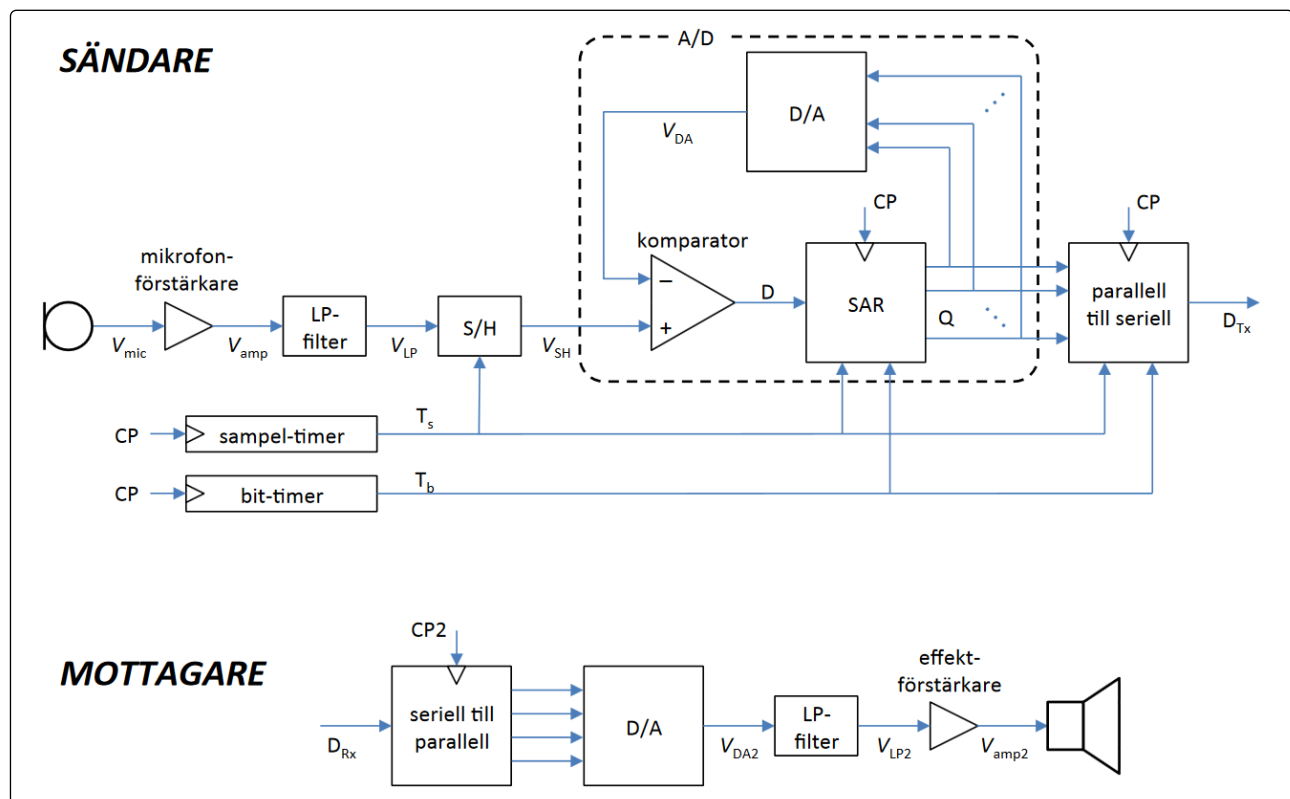


Figure 1: Block diagram of the complete audio transmission system.

Functionally, the system should be capable of receiving audio within the 20-12000Hz frequency range, digitize it and transmit it via a serial link using the RS-232 communication protocol to a receiver (using the exact same hardware) that then converts the digital data back to analog information and outputs it as standard 'line level' audio.

In order to realize this relatively simple functionality in practice, the subsystems required included signal amplifiers, power amplifiers (class AB), 4th order LP-filters, Sample & Hold circuits, DACs (Digital to Analog converters) and ADCs (Analog to Digital converters). Most of these subsystems were controlled by timed sequential and combinational networks on the FPGA.

2 Subsystems

This section will explain each subsystem in detail including its design specification, implementation in hardware and software and subsequent testing and verification.

Hardware designs are constrained to standard values, E12 for resistors and E6 for capacitors and component value calculations will take this into account.

Figures and code may be edited to remove elements that are not strictly relevant to the function of the subsystem at hand. Complete schematics and code can be found in the Appendix.

2.1 Counter/Clock Generation

As seen in the block diagram in figure 1, clock signals control most of the subsystems and it is thus vital to the functionality of the system as a whole that they are sufficiently accurate and, in the case of subsystems that use both clocks, synchronized (ie. without *drift* relative to each other).

Two clock signals, the sample-clock and bit-rate-clock or T_s and T_b respectively are generated by the FPGA, based on its internal 50MHz clock. T_s has a frequency 24kHz and duty-cycle of 5% whereas T_b has a frequency of 240kHz and a duty cycle of 20ns (ie. a single clock-pulse). These particular frequencies are chosen in order to satisfy the Shannon-Nyquist sampling theorem which states that the sampling frequency, f_s , must be twice that of the sampled signal's frequency, f . Furthermore, the generated clock frequencies must be within 5% of that of the receiver's, as required by the RS-232 protocol.

The timings for these clock-signals are generated using two internally clocked registers that are incremented on each internal clock-pulse until they match preset values, whereupon the output signals change and/or the counters are reset.

Code Snippet 1 shows an implementation of the clock generators, albeit at lower frequencies than in the specification (though with the correct ratios) in order to aid in debugging.

Proper timings could be verified directly using an oscilloscope. The results from the implementation in Code Snippet 1 are shown in table 1.

Table 1: *Generated clock timings.*

Signal	T_s	T_b
Amplitude	3.3V	3.3V
Period, T	1.042 ms	~25 ns
Frequency	960 Hz	9598 Hz
Pulswidth (at $ V /2$)	52 us	18 ns

Code Snippet 1: Counter

```
1 architecture arch of clock_gen is
2   signal cnt_Ts : std_logic_vector(15 downto 0);
3   signal cnt_Tb : std_logic_vector(13 downto 0);
4 begin
5   proc_Ts: process(CLOCK_50, reset) -- (960 Hz)
6   begin
7     if reset='0' then --Clear counter and pull clock output LOW.
8       cnt_Ts <= (others => '0');
9       clk_Ts <= '0';
10    elsif rising_edge(CLOCK_50) then
11      if cnt_Ts = 49475 then -- at 95% of period set clock output HIGH.
12        clk_Ts <= '1';
13        cnt_Ts <= cnt_Ts + 1;
14      elsif clk_Ts = 52079 then -- at end of period (note: (52079 + 1)*20ns => 960Hz).
15        clk_Ts <= '0'; -- set clock output LOW and reset counter.
16        cnt_Ts <= (others => '0');
17      else
18        cnt_Ts <= cnt_Ts + 1;
19      end if;
20    end if;
21  end process;
22
23  proc_Tb: process(CLOCK_50,reset) -- (9600 Hz)
24  begin
25    if reset='0' then -- --Clear counter and pull clock output LOW.
26      cnt_Tb <= (others => '0');
27      clk_Tb <= '0';
28    elsif rising_edge(CLOCK_50) then
29      if cnt_Tb = (5207 - 1) then -- 1 clock-cycle before period end, set clock output
30        --> HIGH.
31        clk_Tb <= '1';
32        cnt_Tb <= cnt_Tb + 1;
33      elsif cnt_Tb = 5207 then -- end of period, set clock output LOW.
34        clk_Tb <= '0';
35        cnt_Tb <= (others => '0');
36      else
37        cnt_Tb <= cnt_Tb + 1;
38      end if;
39    end if;
40  end process;
end architecture;
```

2.2 D/A converter

The primary function of the D/A converter (or DAC) is to receive a digital parallel byte (0-255) and output a corresponding analog voltage (-5V to +5V). Furthermore, it should perform the conversion faster than the nominal sample-rate of the system, 12kHz.

The DAC subsystem consists of two active components: an integrated DAC chip with a parallel byte input and a corresponding analog output *current* and a current to voltage converter (*transimpedance amplifier*). The characteristics of these components are determined by auxiliary passive components which must be calculated according to the desired operation mode.

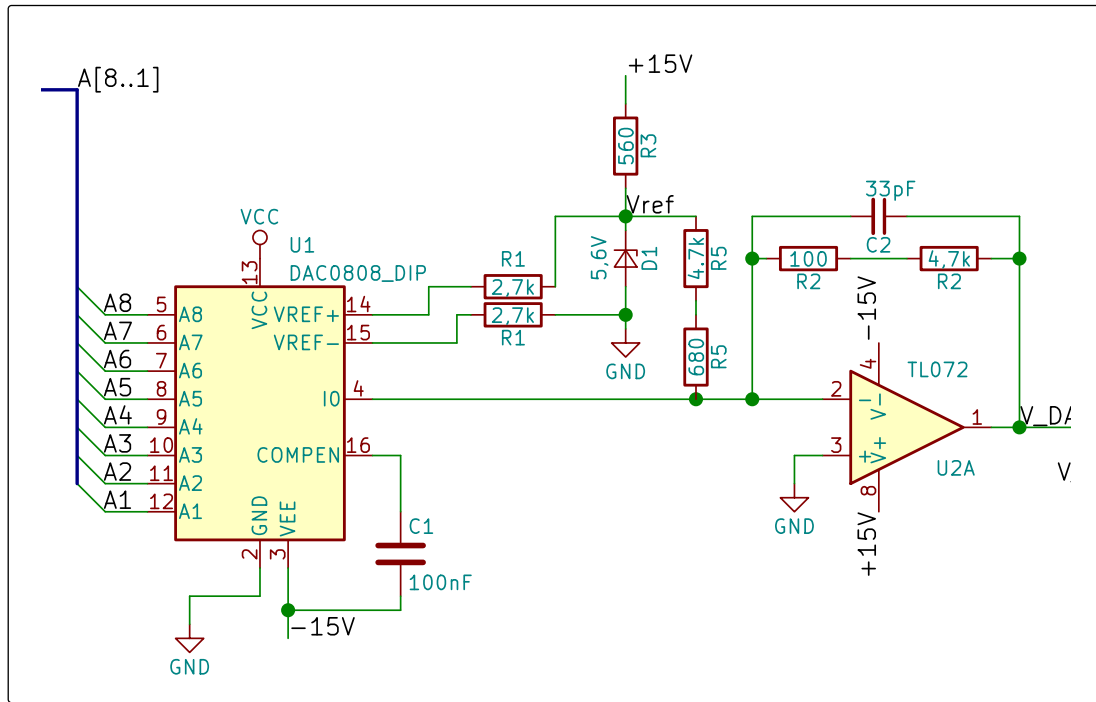


Figure 2: DAC subsystem.

2.2.1 Calculating component values

Several design constraints had to be observed when calculating the component values (refer to the circuit diagram in figure 2 for component, current and node names and values):

- $I_{14} \approx 2\text{mA}$.
- $I_{R_5} \approx 2\text{mA}$.
- $I_{Z_{\text{ener}}} > 10\text{mA}$ in order to stabilize the zener voltage, V_{REF} .
- $I_{R_3} < 20\text{mA}$ in order to protect R_3 .
- V_{DA} should range from -5V to 5V.

First, R_1 may be calculated based on the fact that $I_{14} \approx 2\text{mA}$

$$R_1 = \frac{V_{\text{REF}}}{2\text{mA}} = \frac{5.6\text{V}}{2\text{mA}} = 2.7\text{k}\Omega \quad (1)$$

R_3 can then be calculated, as the currents at V_{REF} are known. First we let $I_{\text{zener}} > 10\text{mA}$

$$R_3 < \frac{15\text{V} - 5.6\text{V}}{10\text{mA} + 2\text{mA} + 2\text{mA}} = 671\Omega \approx 560\Omega \quad (2)$$

then we pick the nearest lower standard value resistor in order to allow for marginally more current than we originally calculated.

Here we deviate slightly from the specification and calculate R_2 for a non-bipolar DAC with a range from 0 to 10 V. This is important, as it temporarily eliminates R_5 while allowing us to examine the characteristics of the subsystem at the same voltage range. The 'conversion' formula for the DAC IC (DAC0808) is as follows

$$I_4 = I_{14} \frac{A}{256} \quad (3)$$

, where A is the digital input to the DAC0808 (ie. 0-255). With some quick circuit analysis we can quickly determine the equation for R_2 as

$$R_2 = V_{DA} \cdot \frac{R_1}{V_{\text{REF}}} \frac{256}{A} \quad (4)$$

Letting $V_{DA} = V_{DA\text{MAX}} = 10\text{V}$ and $A = A_{\text{MAX}} = 255$ gives

$$R_2 = 4840\Omega \approx 4.8\text{k}\Omega = 4.7\text{k}\Omega + 100\Omega$$

From here, it is relatively easy to determine a formula for R_5 in much the same manner, being mindful of the fact that we are moving the operating point to a level at which the DAC is bipolar. V_{DA} can now be expressed as

$$\begin{aligned} V_{DA} &= I_2 \cdot R_2 \\ &= (I_4 - I_5) R_2 \\ &= \left(I_{14} \cdot \frac{A}{256} - I_5 \right) \cdot R_2 \\ &= \left(\frac{V_{\text{REF}}}{R_1} \frac{A}{256} - \frac{V_{\text{REF}}}{R_5} \right) \cdot R_2 \end{aligned} \quad (5)$$

If we let A and V_{DA} take on their extreme values (ie. $\pm 5\text{V}$) we get

$$R_5 = 5374\Omega \approx 5.38\text{k}\Omega = 4.7\text{k}\Omega + 680\Omega$$

2.2.2 Test & Verification

The DAC was tested in its non-bipolar state in which the output range is between approx. 0V and 10V. Constant digital test inputs were used and the corresponding outputs were measured as well as theoretically calculated, as shown in table 2.

Table 2: *Measuring the analog output in relation to the digital input.*

Digital Input (decimal)	Theoretical Analog Output	Measured Analog Output
0	0	0
16	0.622	0.635
32	1.244	1.271
64	2.488	2.547
128	4.977	5.094
255	9.916	10.140

In order to test the linear as well as the step-response (or slew-rate) of the DAC, the FPGA was programmed to output a parallel digital signal in such a way that would result in a sawtooth wave on the output. The code implementation is shown in code snippet 2. The program increments or decrements a parallel byte at a rate determined by the generated bit-rate clock, implemented in chapter 2.1, but configured to run at 100 Hz. This byte is then outputted over the DE1's GPIO header to the DAC0808 IC. Whether this value increases or decreases depends on the state of a toggle switch, SW9. This allows control over whether the sawtooth signal and the 'step' at the transition between periods is rising or falling.

Code Snippet 2: Counter

```

1  -----
2  -- Process: proc_bin_cnt
3  -- Description: 100Hz binary counter.
4  --             Increments or decrements depending on the state of SW9.
5  --             Creates a sawtooth pattern by allowing bin_cnt to over/underflow.
6  -- Input(s) : CLOCK_50, SW9, reset
7  -- Output(s):
8  -- Internal Signals: bin_cnt
9  -----
10 proc_bin_cnt: process(CLOCK_50, reset)
11 begin
12     if reset='0' then
13         bin_cnt <= (others => '0');
14     elsif rising_edge(CLOCK_50) then
15         if clk_Tb_buff='1' and SW9='1' then -- if toggle switch HIGH...
16             bin_cnt <= bin_cnt + 1;         -- count up.
17         elsif clk_Tb_buff='1' and SW9='0' then -- else count down.
18             bin_cnt <= bin_cnt - 1;
19         end if;
20     end if;
21 end process;
22 end arch;

```

The resulting sawtooth signal has a theoretical period length of $\frac{256}{100} = 2.56s$ and a measured period length of approximately 2.60s.

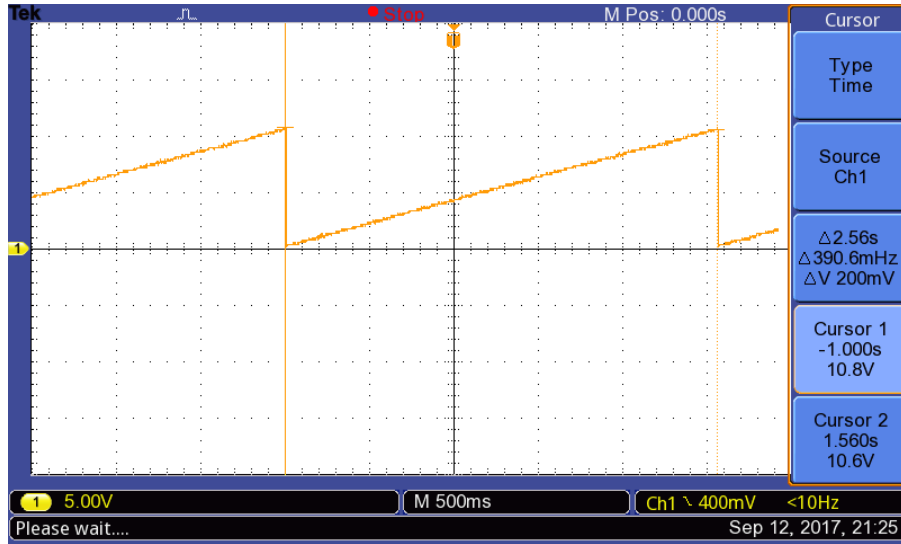


Figure 3: 2.6Hz sawtooth signal generated by the FPGA.

Having ascertained the accuracy of sawtooth generator, the frequency was changed to 9600 Hz in order to examine the 'slew rate' of the DAC, that is, how quickly the output V_{DA} responds to a change on the digital input. This was measured on the 'step'-transitions under two conditions: with and without the inclusion of C_2 (see figure 2).

$$\begin{cases} \text{With } C_2 & : \text{SR} = 11.3V \mu s^{-1} \\ \text{Without } C_2 & : \text{SR} = 6.1V \mu s^{-1} \end{cases}$$

The step response resulted in rather significant ringing however, as seen in figure 4, which effectively limits the bandwidth. The maximum frequency of the DAC can then be estimated (on the presumptions that the output signal is allowed to settle before each transition, and that the fall time is similar in length).

$$f_{MAX} = \frac{1}{\text{rise-time} + \text{fall-time}} \approx 200\text{kHz} \quad (6)$$

This may seem as though it fails to meet the required bandwidth of 240 kHz, but under normal conditions the input will not jump between it's extreme values and so it will not be limited.

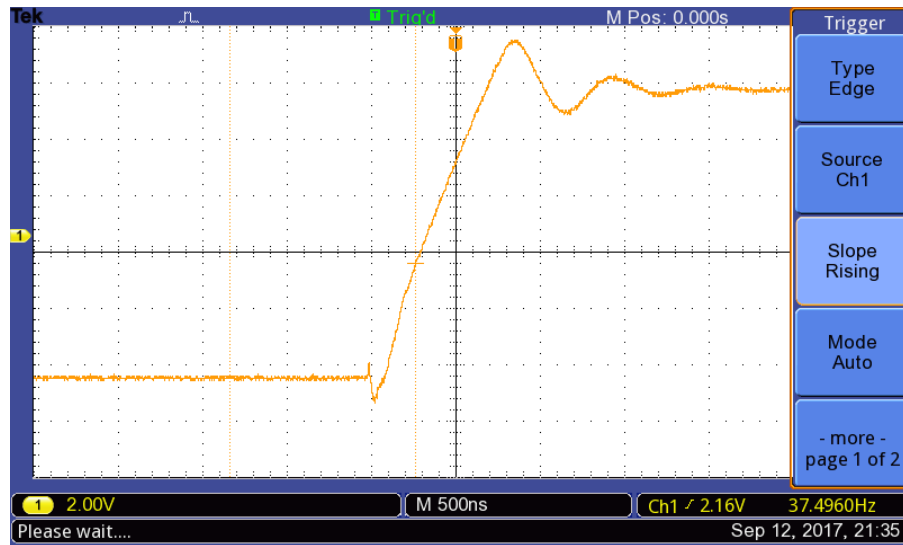


Figure 4: Ringing on the DAC output during a large 'step' in the input signal.

2.3 A/D converter

The function of the ADC (Analog to Digital Converter) is to convert an analog signal of $\pm 5V$ to an 8 bit digital representation (ie. 0-255). The ADC contains three main components: an FPGA implementation of a SAR (Successive Approximation Register) state-machine, a DAC (previously introduced in chapter 2.2) and a comparator based on the LM311 IC. The full circuit is shown in figure 5.

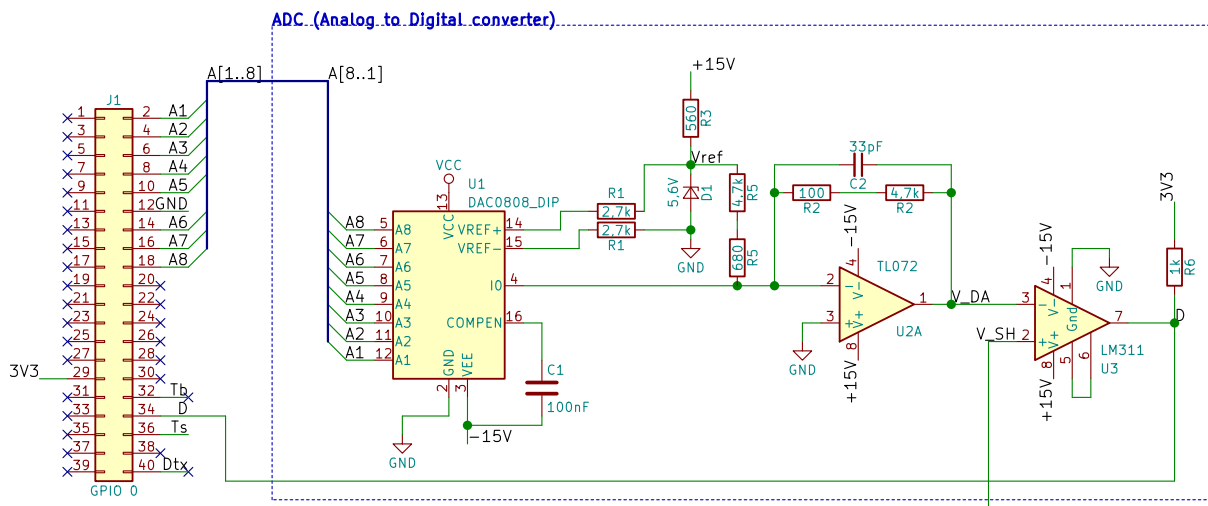


Figure 5: ADC circuit diagram. To the left is the FPGA's GPIO connector, in the middle is the DAC subcircuit and to the right is the voltage comparator.

The system can be thought of as having the SAR as its main component and the DAC in series with the comparator as a feedback signal. This feedback signal is labeled 'D' in the circuit diagram.

The functional principle of the ADC can be described with the help of both the circuit diagram and the SAR state-machine diagram in figure 6. The signal to be converted is inputted on V_{SH} .

To start a conversion the SAR receives a T_s pulse. It then sets its parallel output (A1-A8 in the circuit diagram) to $(10000000)_2$ ie. half of the maximum range of the DAC. This value is converted by the DAC to an analog voltage and passed on to the comparator, where it compared to the input signal. If the input signal exceeds the signal generated by the SAR, 'D' is pulled HIGH in logic terms, else LOW. The SAR will then store this value of 'D' in the MSB position of its eventual converted digital output.

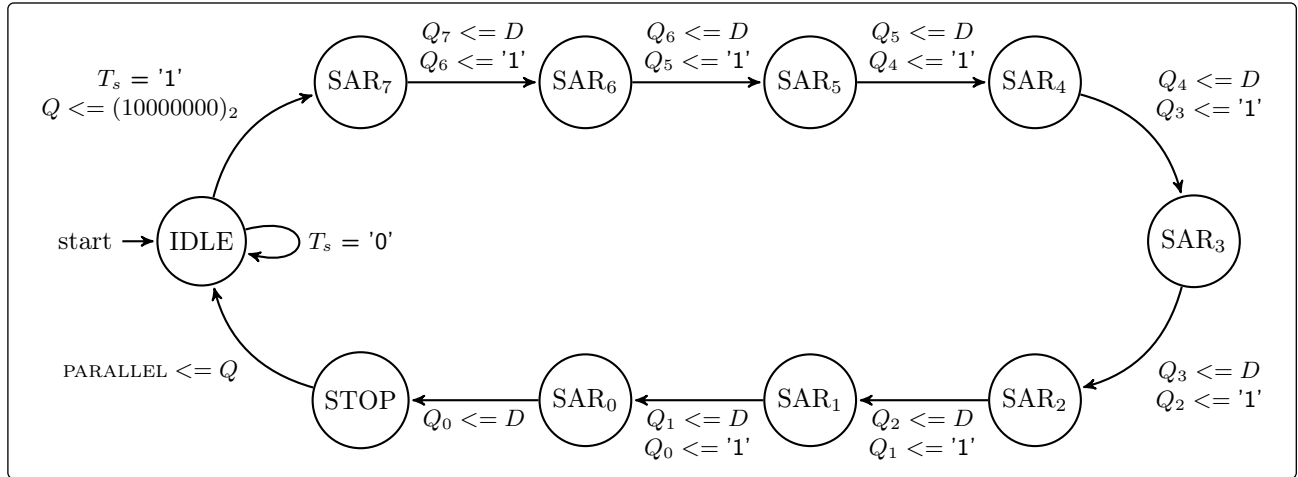


Figure 6: *Finite state-machine describing the SAR's function.*

Next, the SAR sets the MSB-1 of its parallel output HIGH, while keeping the previous value of the MSB, and the process repeats, doing so for each bit until the complete digital byte representation is determined.

The way in which this successive approximation takes place is perhaps best seen on a time-graph such as in figure 9.

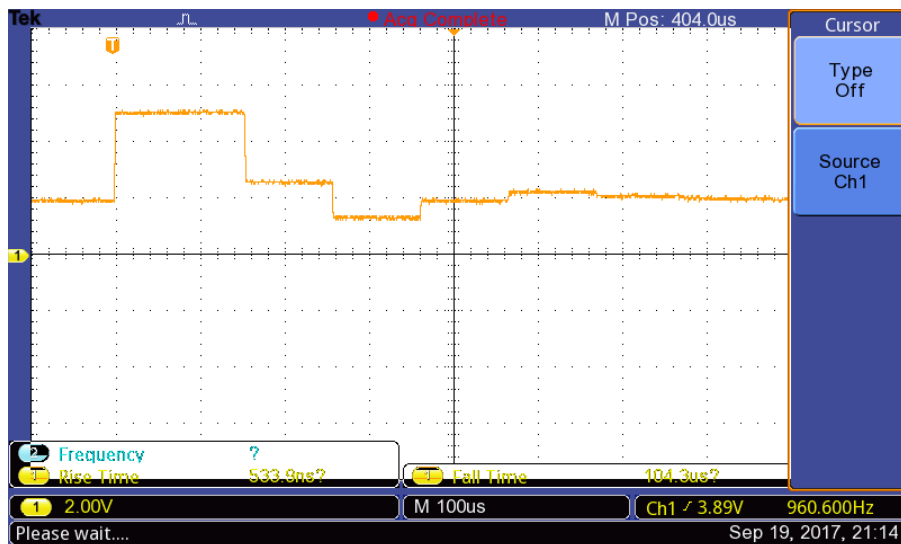


Figure 7: *ADC successively converging on 1.9V. Note: the ADC used in this image is not bipolar!*

The VHDL implementation of the SAR below shows how the SAR solves bits with a case structure by saving the current state and moving to the next state. In this process there

are three input signals state, SAR and Q. "Q" is the signal which will provide changes to the output voltage and "state" continues the bitlow by incrementing by 1 after each set bit. If V_{DA} approximation higher than sampled signal, D is set LOW, and thus also Q(n). When the voltage has converged the state will move to stop and loop back into the idle state and wait for the next TS signal..

Code Snippet 3: SAR Implementation as a VHDL Process

```
1  proc_SAR_comb : process(CLOCK_50,reset)
2      begin
3          if reset='0' then
4              state <= IDLE;
5              SAR_result <= (others => '1');
6          elsif rising_edge(CLOCK_50) then
7              if clk_Ts='1' then
8                  Q <= "10000000"; -- MSB set, first approximation is half of maximum value.
9                  state <= SAR7;      -- Switch to next state in sequence.
10             elsif clk_Tb='1' then
11                 case state is
12                     when SAR7 =>
13                         Q(7) <= D; -- If V_DA approximation higher than sampled signal,
14                                     -- D is set LOW, and thus also Q(n).
15                         Q(6) <= '1'; -- Add 1/4 of maximum value to approximation,
16                                     -- and so on for subsequent states.
17                         nextState <= SAR6;
18                     when SAR6 =>
19                         Q(6) <= D;
20                         Q(5) <= '1';
21                         nextState <= SAR5;
22                     .
23                     .
24                     . -- (truncated)
25                     .
26                     .
27                     when STOP =>
28                         nextState <= IDLE; -- wait for next Ts trigger.
29                         SAR_result <= Q;
30                     when IDLE | U =>
31                         -- do nothing
32                     end case;
33                 end if;
34             end if;
35         end process;
```

The A/D converter consists of an LM311 chip which is used to compare voltage sources from D/A as well as the sample and hold circuit. The input sources are compared to create a digitalized source of power through recursive comparisons of the voltage from a D/A converter with the desired analog signal. The LM311 chip uses three state logic which consists of a logical zero and a high impedance state "Z". When the sample and hold circuit outputs a greater voltage than the DAC, the SAR will interpret the signal as a logical one and increase

the digital voltage output.

$$\begin{cases} V_{out} = 0 : & V_{SH} > V_{DA} \\ V_{out} = Z : & V_{SH} < V_{DA} \end{cases} \quad (7)$$

Table 3: *DC inputs and corresponding ADC output.*

Analog DC Input [V]	Theoretical Digital Output	Measured Digital Output
-5	00000000	00000011
-2	01001101	01001111
-1	01100111	01101111
0	10000000	10000001
1	10011010	10011111
2	10110010	10110101
5	11111111	11111111

The testing provided a table which showed that the conversion displayed rounding errors. The ADC rounding error was calculated to be about 0.4 percent off target value as a worst case scenario, which may or may not be acceptable depending on the application.

The ADC converts with is restrained by a delay which is the creating a maximum bitratio. The theoretical delay was calculated in the simulation below. The delay was calculated to around 800 ns.

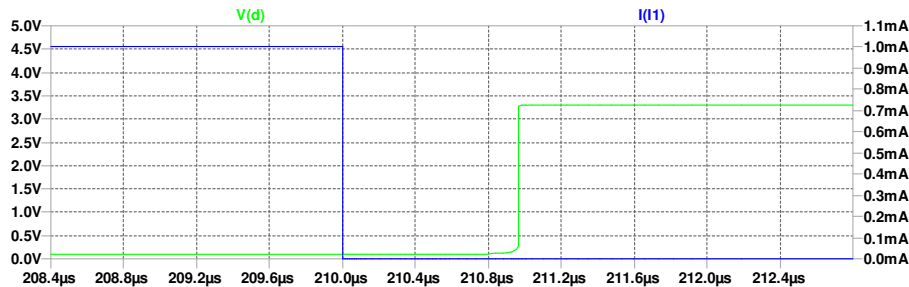


Figure 8: *Q->D falling edge*

To be able to calculate the ADC maximum bitratio the delay of the ADC has to be known. The delay can be interpreted as the fall time of the Q signal until the stability of the D signal. With this we can then equate the bit transfer to be the frequency differential of these signals. By triggering the oscilloscope on a negative flank on the signal Q, the delay could be calculated to 850 ns. With this delay the maximum bit ratio could then be calculated to be 1.18 Mb/s.

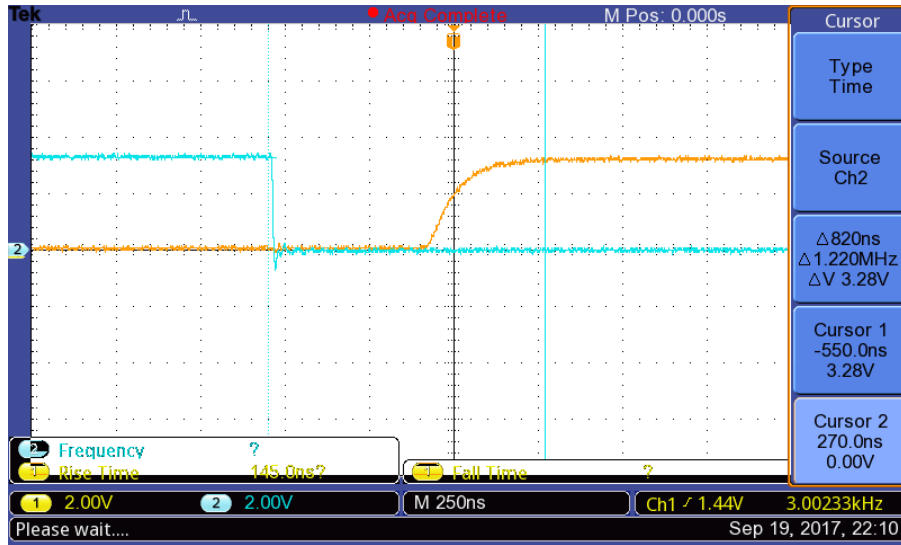


Figure 9: $Q \rightarrow D$ falling edge

2.4 Sample and hold

In order for the ADC to accurately convert an analog voltage, it must be held constant for the duration of the conversion. A S/H (Sample & Hold) circuit uses an external control signal (in this case the sample-clock, T_s) to either sample or 'hold', that is, keep the voltage constant.

The S/H achieves this behaviour by allowing the voltage over its capacitor (see figure 10) to vary with the input signal during 'sample' mode.

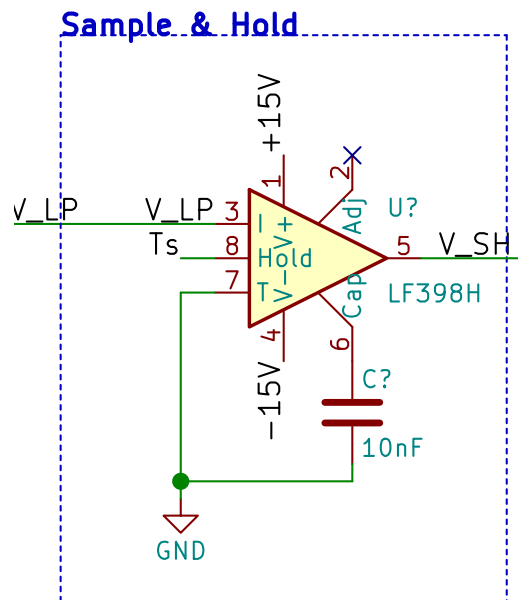


Figure 10: S/H circuit. The 10nF capacitor is responsible for 'holding' the sampled voltage.

The circuit used in this project uses the purpose-designed IC LF398 which has the following two states

$$\begin{cases} \text{Sample :} & V_8 - V_7 > 1.4V, \\ \text{Hold :} & V_8 - V_7 < 1.4V \end{cases} \quad (8)$$

Using this relationship and considering that the FPGA uses LVTTTL (ie. 3.3V logic), setting $V_7 = \text{GND}$ and $V_8 = T_s$ (the sample clock) gives us the required behaviour. The fact that T_s has a 5% duty cycle means that there is always enough time for the capacitor to reach the level of the input signal before it is 'held'.

A comparison between the input and output signals from the S/H can be seen in figure 11, while the input signal is a triangle wave of an arbitrary frequency, the output samples the input and holds it constant with a frequency of 960Hz.

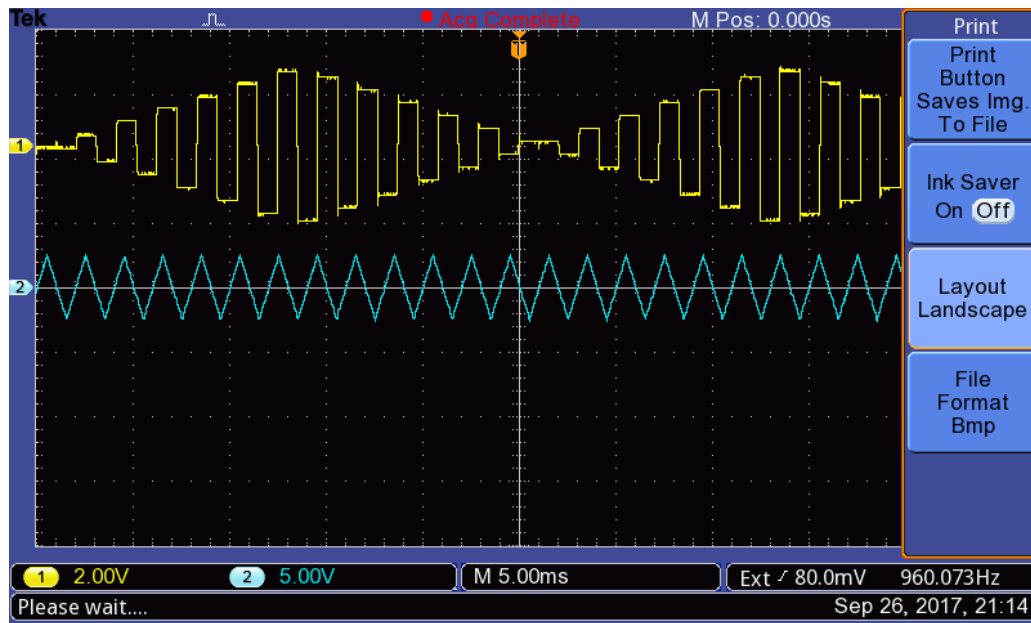


Figure 11: The input signal (blue) is a triangle wave that gets periodically sampled by the S/H. The resulting output signal (yellow) is held between samples.

2.5 Serial transmitter

The serial transmitter is implemented in software using a shift register and makes use of the DE1's onboard RS-232 port to translate between logic and the RS-232 specified voltage levels, which in the DE1's implementation range between $\pm 8\text{V}$ (-8V being logic '0' and $+8\text{V}$ being logic '1').

The data to be transmitted is the parallel byte 'Q', generated by the ADC in chapter 2.3. The serial transmitter completes the byte with a START bit (logic '0') before the LSB and a STOP bit (logic '1') after the MSB, according to the RS-232 protocol, before transmitting the complete 10-bit packet LSB first. When idling, the transmitter outputs a continuous STOP bit.

The serial transmitter's operation is triggered by a T_s pulse and each individual bit is then sent upon receiving a T_b pulse.

Code Snippet 4: Shift Register

```
1  proc_shift_register: process(CLOCK_50, reset)
2      begin
3          if reset='1' then
4              SR <= (others => '1'); -- Init. SR with STOP bits.
5          elsif rising_edge(CLOCK_50) then
6              if SR_start='1' then -- Shift Register activated?
7                  if clk_Ts='1' then
8                      SR <= SAR_result & '0'; -- Load Shift Register with DATA & START bit.
9                  elsif clk_Tb='1' then
10                     SR <= '1' & SR(8 downto 1); -- Shift data right, Shift in STOP bit.
11                 end if;
12             end if;
13         end if;
14     end process;
15
16  serial <= SR(0); -- Serial output from LSB of Shift Register
```

Code snippet 4 shows a VHDL process implementing the serial transmitter. 'SR' is the contents of the shift register, ie. the complete packet to be sent, 'SAR_result' is an intermediate register to hold contents of Q (Q itself cannot be used as the ADC and serial transmitter operate in parallel, and Q would then change before it was fully sent!). 'SR_start' is simply a flag indicating whether at least one ADC conversion has taken place, so that the transmitter under no circumstances transmits undefined data.

As seen in the code, a positive T_s signal reads the data to be sent into the shift register prepended by a START bit. A positive T_b signal then causes the shift register to logical shift right while also shifting in a STOP bit from the left (that is, in the MSB position). The LSB of the shift register is continuously outputted on the serial link. Eventually the shift register will contain and therefore output only STOP bits, which will be interpreted by the receiver as a complete transmission (or otherwise serve to synchronize the transmitter and receiver, see the next chapter).

The serial transmitter was tested by allowing the ADC to convert a known external DC voltage, and transmitting the resulting byte to a PC-based receiver. On a successful transmission the

PC interpreted the information as an ASCII character, which was then compared to both the theoretical digital value of the input signal as well as the result of the conversion in the ADC, which was outputted directly to 8 debug LEDs by the FPGA.

2.6 Serial Receiver

The serial receiver (hereafter R_x) should be able to asynchronously interpret an incoming stream of serial bits as data packets according to the RS-232 protocol, and output the encapsulated data as a parallel byte. It is in this sense a serial to parallel converter, the opposite of the serial transmitter (hereafter T_x) in 2.5. Also in accordance with the RS-232 protocol, the R_x should be able to automatically synchronise itself to the T_x (using clock recovery/symbol synchronization) and compensate for both clock drift (the frequencies of T_x and R_x do not exactly match) and triggering a read at the wrong position in a packet (block synchronisation).

The receiver is implemented in software and utilizes the DE1's onboard serial port. To implement the functionality described above, a state machine (of type Mealy) is used as described in figure 12.

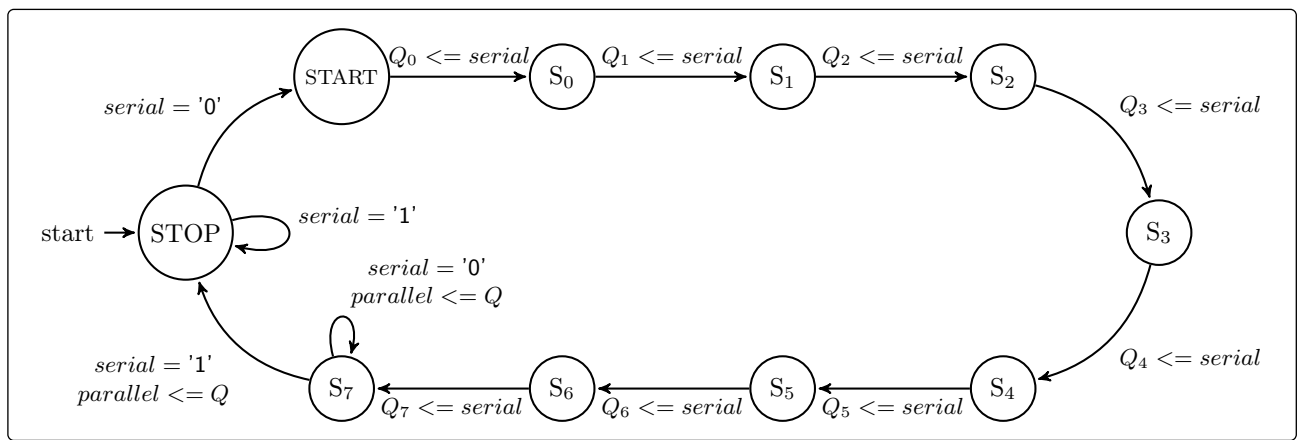


Figure 12: *Finite state-machine describing an 8-bit serial to parallel RS-232 receiver.*

The receiver initializes in the STOP state where it is assumed that it is receiving STOP-bits ('1') and waits for a START-bit, indicating the start of a packet, before transitioning to the START state. It then successively transitions from the START state to the S7 state at a rate determined by an internally generated sample-clock, reading a bit from the packet at each transition. Once at the S7 state, it awaits a STOP-bit while still sampling with the same frequency. By *synchronously* waiting until this STOP bit is received, the position in the packet where the next read will start is moved, effectively resulting in block synchronization. Once the STOP-bit is received it transitions back to the STOP state and awaits the next START-bit. However, unlike previously, it will start the next read immediately (asynchronously) upon receiving the START-bit. This results in clock drift compensation as the R_x and T_x are essentially resynchronised on each new start, and any drift in the relative timings is nullified.

The code implementation of the state machine is shown in code snippet 5. In keeping with the model of a Mealy machine, the state machine is implemented as two processes: a synchronous and an asynchronous/combinational part. The combinational part handles the logic that determines outputs and state changes, whereas the synchronous part handles timings and synchronously latches the combinational logic.

Also note that the synchronous process reads or 'samples' each data bit in the middle of its period in order to get the most reliable reading.

Code Snippet 5: Serial Receiver

```
1  proc_Rx_sync : process(CLOCK_50, reset) -- Synchronous process.
2      begin
3          if reset='0' then
4              state <= STOP;
5              Q <= (others => '0');
6              cnt <= (others => '0');
7          elsif rising_edge(CLOCK_50) then
8              cnt <= cnt + 1;
9              if (state = STOP AND serial = '1') then -- If state is STOP and receiving
10                 ↪ STOP-bits...
11                 cnt <= (others => '0'); -- ...reset counter and await START. (Block
12                 ↪ synchronization)
13
14             elsif cnt = 103 then -- At half of period T, sample data and transition to
15                 ↪ next state.
16                 state <= next_state;
17                 Q <= next_Q;
18                 parallel <= next_parallel;
19             elsif cnt = 207 then -- At full period T, reset counter.
20                 cnt <= (others => '0');
21             end if;
22         end if;
23     end process;
24
25  proc_Rx_comb : process(state, serial, Q) -- Combinational process.
26      begin
27          next_Q <= Q;
28          case state is
29              when STOP =>
30                  next_state <= START;
31              when START =>
32                  next_state <= S0;
33                  next_Q(0) <= serial;
34              when S0 =>
35                  next_state <= S1;
36                  next_Q(1) <= serial;
37              ..... -- continuing for Q2-6
38              when S6 =>
39                  next_state <= S7;
40                  next_Q(7) <= serial;
41              when S7 =>
42                  next_parallel <= Q;
43                  if serial='0' then -- If serial is NOT STOP-bit ...
44                      next_state <= S7; -- ... do nothing. (Drift compensation)
45                  else -- If serial is STOP-bit...
46                      next_state <= STOP; -- transition to STOP state.
47                  end if;
48              when others =>
49                  -- undefined state
50                  next_state <= STOP;
51          end case;
52      end process;
```

The serial receiver was tested by linking it to a PC-based serial transmitter and configuring

both for 9600 baud. ASCII characters were then sent from the PC and the resulting parallel byte on the receiver's output was directly displayed by the FPGA using 8 LEDs. The test results can be seen in the table below.

Table 4: *Sent ASCII characters and resulting bit-patterns and voltages D/A conversion. Note that the receiver's DAC is bipolar at this stage.*

ASCII-character	Received bit-pattern	Measured Analog Output [V]
P	01010000	-1.95
?	00111111	-2,62
ä	10000110	0.17
!	00100001	-3,80
=	01011101	-2,70
A	01000001	-2,54

2.7 Audio Amplifier

There are two audio amplifiers in the system: the transmitter has a signal amplifier for the microphone and the receiver has a power amplifier for the speaker. The difference is that the signal amplifier increases the amplitude of the microphone's signal to match the range of the ADC (ie. $\pm 5V$), whereas the power amplifier increases the amount of power that can be delivered to the load without substantially changing the amplitude.

2.7.1 Characterising the signal amplifier

The microphone and signal amplifier subcircuit is shown in figure 13.

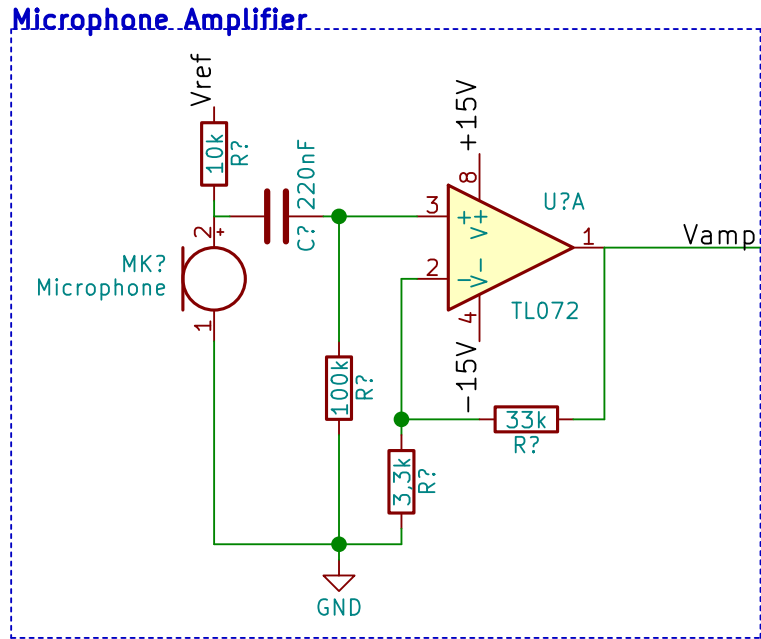


Figure 13: An analog signal is generated by the microphone and amplified by the OP-amp on the right.

In order to calculate the input impedance Z_{in} of the signal amplifier from the perspective of the microphone, the small signal circuit must be considered. If we let the microphone act as a current source, short any external voltage sources and consider the OP-amp ideal (in that it draws no current on its comparator inputs), then

$$Z_{IN} = \frac{10k\Omega \cdot 100k\Omega}{10k\Omega + 100k\Omega} = 9090.9\Omega \quad (9)$$

Since this result differs from the specification's $2k\Omega$, the sensitivity of the microphone will be affected and must be recalculated.

Since the microphone's specification gives a typical sensitivity of $-39dB V Pa^{-1} @ 2k\Omega$ input impedance, we can express this as an *effective* (RMS) voltage

$$U_{eff} = 1V \cdot 10^{\frac{-39}{20}} = 0.0112V \quad (10)$$

in order to calculate a current at the specifications input impedance

$$I_{eff} = \frac{U_{eff}}{Z_{IN}} = \frac{0.0112V}{2k\Omega} = 5.61\mu A \quad (11)$$

but at this current with the new input impedance (remember, the microphone can be seen as a *current* source) the effective voltage is

$$U_{eff} = Z_{IN_{new}} \cdot I_{eff} = 9090.9\Omega \cdot 5.61\mu A = 0.051V \quad (12)$$

giving the new sensitivity

$$20\log\left(\frac{0.051V}{1V}\right) = -25.8\text{dB V Pa}^{-1} \quad (13)$$

It is now possible to calculate the maximum soundpressure that the system can receive before the transduced signal exceeds the range of the ADC, and clipping occurs.

If the amplification of the non-inverting amplifier in figure 13 is $A_U = 11$ and the maximum amplitude after amplification is $|V_{amp}|_{MAX} = 5V$, then the maximum microphone signal amplitude is

$$U_{mic} = \frac{5V}{11} = 0.455 \Rightarrow 20\log\left(\frac{\frac{0.455V}{\sqrt{2}}}{1V}\right) = -9.85\text{dB V Pa}^{-1} \quad (14)$$

at 9090.9Ω input impedance.

Taking the difference between the microphone's maximum output as defined above, and the nominal output yields

$$-9.85\text{dB V} - -25.8\text{dB V Pa}^{-1} = 15.95\text{dB V} \quad (15)$$

which can then be directly added to the nominal SPL (ie. $1\text{ Pa} = 94\text{dB SPL}$).

$$94 + 15.95 = 109.95\text{dB SPL} \quad (16)$$

to get the maximum allowed sound pressure.

Several characteristics were best calculated using SPICE such as the DC operating point, lower cutoff frequency and the amplification of the non-inverting amplifier (using a better mathematical model than the assumed ideal one). The results of these simulations follow in the table below.

Table 5: SPICE simulation of microphone amplifier.

DC Operating Point [V]	Cutoff Frequency [Hz]	Gain
3.08	6.6	10.96

2.7.2 Characterising the power amplifier

The power amplifier circuit is shown in figure 14. The total gain of the amplifier is simple to compute with the approximation that the CMOS amplifier stage has no gain and that the capacitor can be approximated by a short. This leaves two potential dividers with a non-inverting amplifier in between them, also acting as a convenient buffer.

$$\text{Thus } A_U = \frac{1k\Omega // 47k\Omega}{10k\Omega + 1k\Omega // 47k\Omega} \cdot \frac{33k\Omega + 10k\Omega + 100\Omega}{10k\Omega} \cdot \frac{20\Omega}{20\Omega + 47\Omega} = 0.115 \quad (17)$$

Power Amplifier

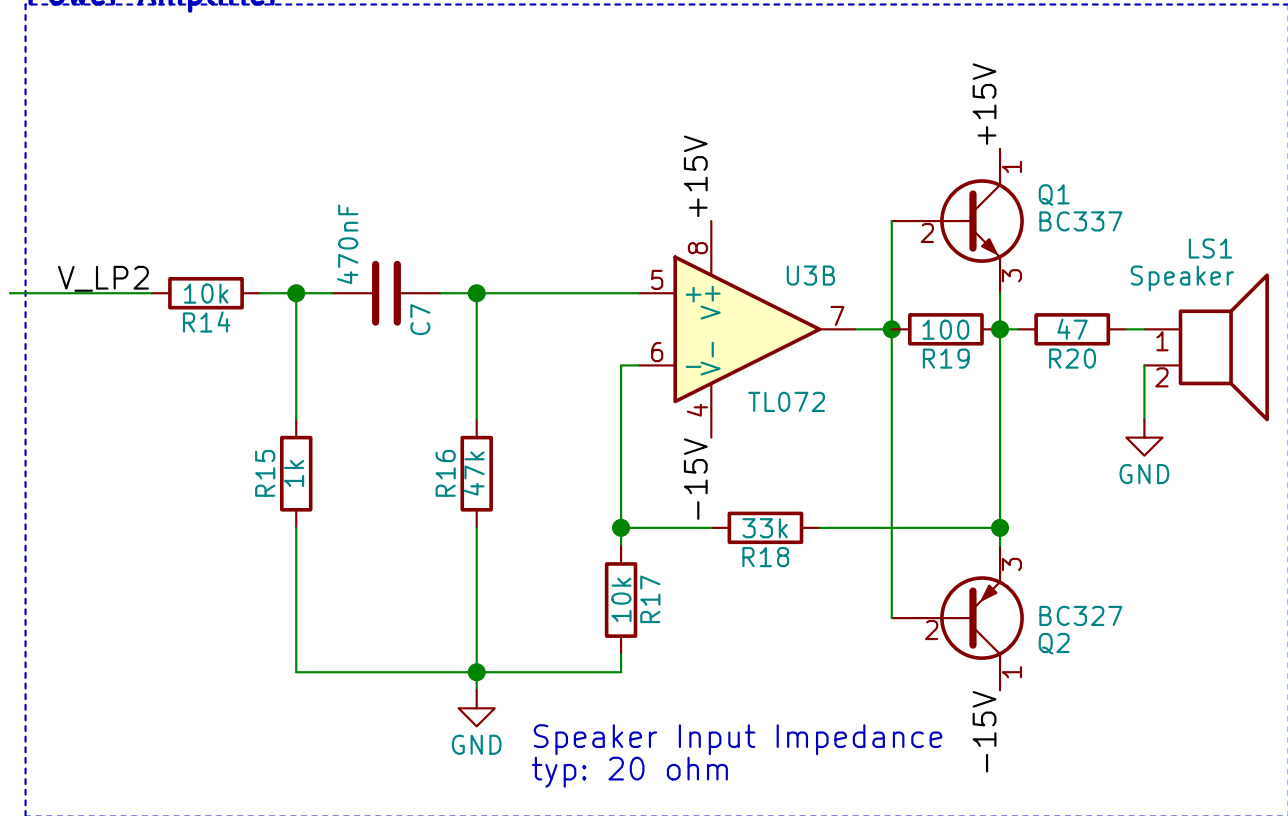


Figure 14: The power amplifier shown here consists of several cascaded stages. From right to left: a potential divider, a passive HP-filter, a non-inverting amplifier, a CMOS amplifier and another potential divider in which the speaker completes the divider.

The maximum SPL that a typical speaker with sensitivity of 100 dB SPL/mW can generate with a 5V AC input can now be calculated.

$$P_{\text{MAX}} = \frac{\left(\frac{5V \cdot 0.115}{\sqrt{2}} \right)^2}{20\Omega} = 8.26\text{mW} \quad (18)$$

$$\Rightarrow 10\log\left(\frac{8.26\text{mW}}{1\text{mW}}\right) = 9.17\text{dB mW} \quad (19)$$

thus the maximum sound pressure level is

$$100\text{dB SPL/mW} + 9.17\text{dB SPL/mW} = 109.17\text{dB SPL/mW}$$

SPICE was used to simulate a few remaining characteristics and to confirm the gain calculation, with the results presented in the following table.

Table 6: *SPICE simulation of power amplifier. NOTE: power amplification is $\frac{P_{OUT_{MAX}}}{P_{IN_{MAX}}}$.*

Power Amplification	Lower Cutoff Freq. [Hz]	Upper Cutoff Freq. [kHz]	Gain
8	7	172.9	0.115

The power amplifier was tested in practise, which resulted in the gain/frequency curve seen in figure 15.

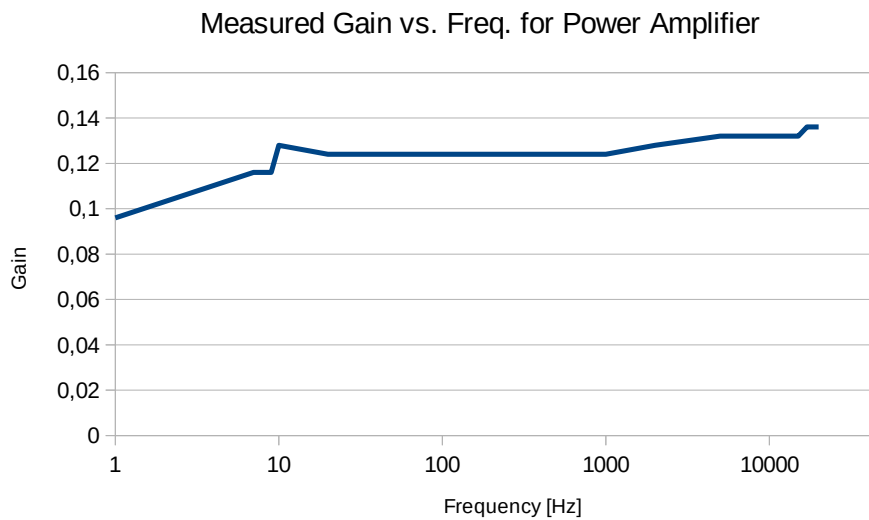


Figure 15: *Measured Gain vs. Freq. for Power Amplifier. Note the attenuation below 10 Hz.*

2.8 LP filter

The system itself is required to inherit a maximum frequency of 12 kilohertz. To fit the requirement the circuit is required to contain a Low Pass filter. The LP filter is designed and calculated as a fourth order butterworth filter.

The equation of a general fourth order butterworth filter:

$$H_s = \frac{1}{1 + 2.613a + 3.414a^2 + 2.613a^3 + a^4} \quad (20)$$

The LP filter simply put, is set to cutoff at the a targeted frequency. The butterworth filter is set to be built in sallenkey filter structure.

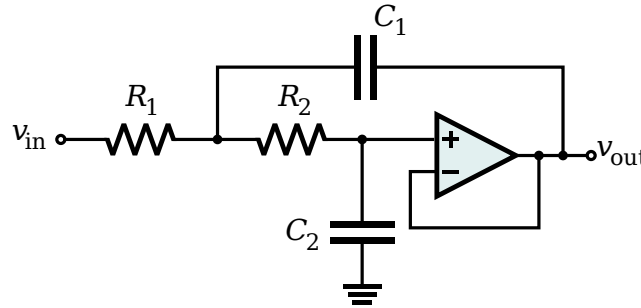


Figure 16: A general LP sallenkey filter

By cascading two second order sallen-key filter structures, the butterworth equation splits into two second order butterworth filters

$$H_s = \frac{1}{(1 + 0.765a + a^2) * (1 + 1.848a + a^2)} \quad (21)$$

To calculate the components for the sallenkey filter which can be equated to the butterworth filter:

$$\frac{1}{(1 + ax + a^2)} = \frac{1}{(1 + (R_1 + R_2)C_2 + R_1R_2C_1C_2)} \quad (22)$$

$$a = \frac{S}{\omega} = \frac{S * 0.765}{F_c * 2\pi} = \frac{S * 0.765}{12000 * 2\pi} \quad (23)$$

Calculating The first sallenkey filter as the first part of the butterworth filter:

$$\frac{1}{(1 + 0.765a + a^2)} = \frac{1}{(1 + (R_1 + R_2)C_2 + R_1R_2C_1C_2)} \quad (24)$$

Let C2 be equal to 1nF and assuming that the resistor are equal

$$2R = \frac{S}{12000 * 2\pi * C_2} \Rightarrow R = 5075\Omega \quad (25)$$

With three known components we can calculate the last capacitor

$$2R = \frac{S^2}{12000 * 2\pi * C_2 * R^2} \Rightarrow C_1 = 6.8nF \quad (26)$$

With the first filter calculated, computing the second filter can be used the same methodology, inserting the second part of the buttworth filter equation we get:

$$a = \frac{S}{\omega} = \frac{S * 1.848}{F_c * 2\pi} = \frac{S * 1.848}{12000 * 2\pi} \quad (27)$$

Let $C2 = 1.5\text{nF}$ and $R1=R2 \Rightarrow$ gives 8200Ω and $C2 = 1,72 \text{ nF}$ which can be rounded to 1.5 nF . With all the components solved they create the schematic:

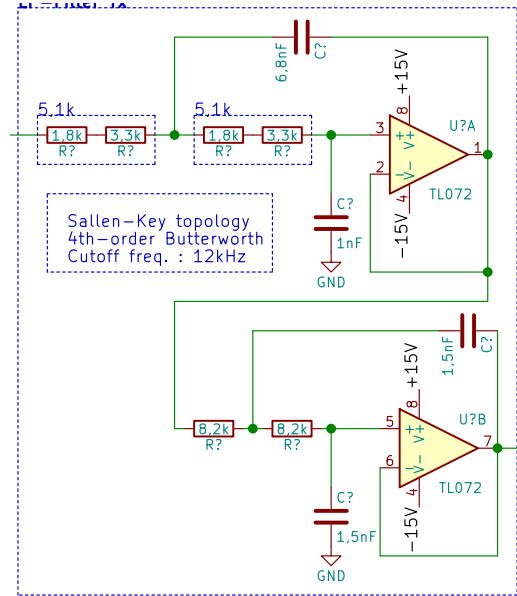


Figure 17: Two sallenkey filters cascaded with calculated component values

Using the above component values, we can implement the filter in LTSpice, giving us the following frequency response plot:

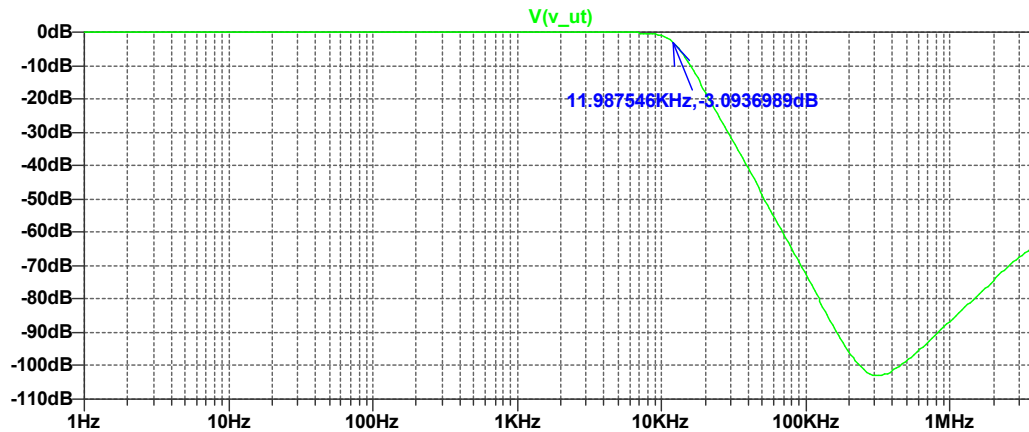


Figure 18: The frequency response curve for the 4th order LP-filter. The cutoff frequency is marked. Note that the attenuation reaches a maximum and then decreases again.

The filter in practice functions as in the simulation whereas the cutoff frequency was located between 11500-12000 Hz.

3 Test and Verification

In order to examine the functionality of the system as a whole, verifying that it was up to specification, an array of measurements were performed. To test both sides of the system, without having to physically build both, we partnered with another lab group and designated our system the receiver and theirs the transmitter.

The first step was to measure the maximum input amplitude that the system can withstand before noticeable clipping occurs on the receiver output. This was done using a 1kHz sine wave and was determined to be

$$U_{IN_{MAX}} = 11V_{pp}$$



Figure 19: Noticeable clipping on the receiver. V_{DA} in Yellow, V_{amp2} in Blue

Likewise, the minimum input amplitude that could be detected before the receiver output was drowned out by noise was

$$U_{IN_{MIN}} = 400mV_{pp}$$

This gives the transmission a *dynamic range* of

$$20\log\left(\frac{11V}{0.4mV}\right) = 28.79dB$$

Secondly, the outputs from the LP-filters on either side were observed and compared, as shown in figure 20.

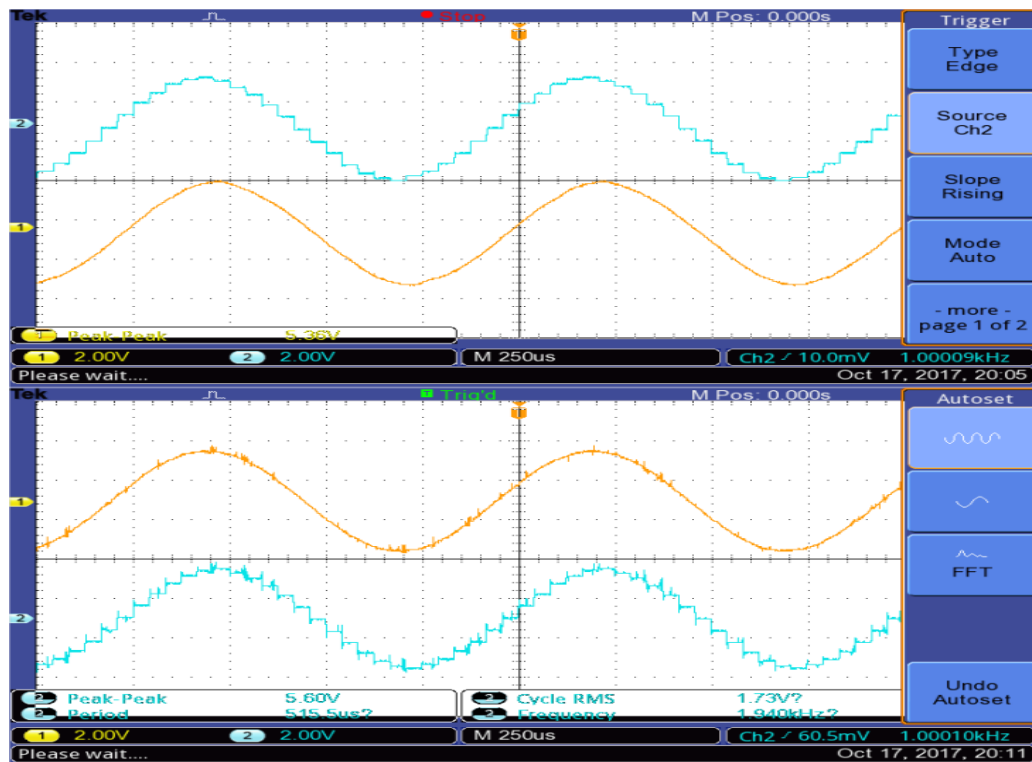


Figure 20: The smooth lines in each image are the filter outputs. R_x on top, T_x below. Note the high frequency components in the latter are not attenuated.

Continuing, the system's bandwidth was examined by adjusting the input signal frequency on the transmitter side at a 11Vpp amplitude. The cutoff frequencies were determined to occur at 900Hz and 3900Hz.

The systems resilience to partial transmission failure was also tested by grounding several of the least significant bits on the transmitter side, thus reducing the resolution of the transmitted data. It was unanimously decided by the group that a minimum of 5 bits of resolution is needed to communicate, anything less was rendered completely unintelligible.

A working example of normal speech transmission at the full 8-bit resolution is illustrated in figure 21.

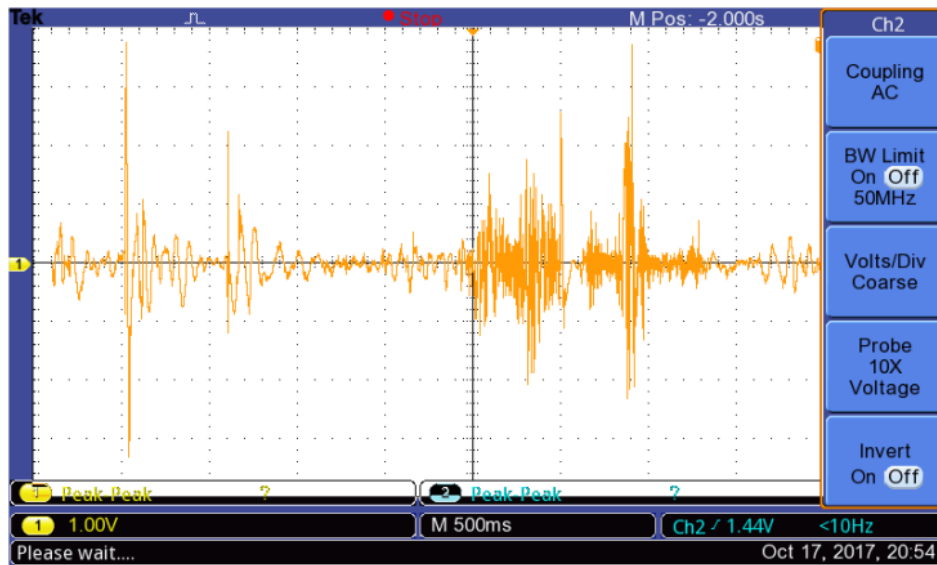


Figure 21: *Input: "jag heter john"*

4 Conclusion

The fact that clipping occurs when $U_{IN} \geq \pm 10V_{pp}$ is entirely expected due to the fact that it exceeds the range of the ADC, indicating that the ADC itself fulfills its specification. In reality, using a regular microphone such as the one the system was designed for (see chapter 2.7.1) would require an exceptionally loud noise before clipping occurred, unlikely to happen under normal circumstances.

The presence of high frequency components on the receiver side of the system was unanticipated and may contribute distortion. These components may be explained by examining the frequency response of the filter used in figure 18. In the graph one can see how the attenuation reaches a maximum before decreasing again, possibly allowing these high frequency components through. The fact that a breadboard is used with no regards to potentially parasitic effects may also contribute.

An area in which the system clearly did not live up to its specification was in the bandwidth. Whereas the specified bandwidth was 20-12000Hz, the actual measured bandwidth was 900-3900Hz, despite the individual subsystems (on the receiver side) performing as required. As we were partnered with another group for the final system test, we cannot account for the performance of the transmitter. An adequate explanation for this poor performance may require further testing of the individual subsystems on both sides of the transmission.

Nevertheless, this bandwidth was sufficient for regular speech, which was described as sounding "like an ordinary telephone". Decreasing the resolution of the sent data, however, quickly resulted in a loss of intelligibility.

On the whole, despite the presence of some undesirable characteristics, the system is eminently functional when used to transmit spoken audio. All the various subsystems have had their individual performances tested and verified and since there is no inherent bandwidth limiting factor, improving the system's characteristics may simply be a matter of debugging the electrical circuit.

5 Reflection

5.1 Preparatory work

The preparatory work required a large time commitment which in all likelihood exceeded the recommended 95 hours. The assignments were often, however, self explanatory and was easily reflected on what was happening inside of the laboratory.

5.2 Equipment

There were a few time consuming issues with the laboratory equipment that usually turned out to be trivial:

- The oscilloscopes can't seem to differentiate between amplitude and peak-to-peak measurements.
- The bench-top power supplies are current limited and due to inexperience a sudden drop in voltage (due to the current limiting kicking in) was interpreted as a short circuit.
- The passives (resistors especially) had very large tolerances which made it difficult to build the theoretical designs with any precision.
- The handheld DMMs cannot seem to adjust to an amplitude-varying AC signal, unlike the benchtop DMMs.

5.3 Teamwork

Teamwork in the preparation assignment was hardly divided since both had to understand and explain the meaning of the laboratory work. Inside of the laboratory the teamwork was divided into one working on coding the FPGA-chip and the other one setting up the new circuits on the breadboard. Then together solve the assignments or troubleshooting the new part of the system.

5.4 Guidance

The guidance was sufficient and wasn't over exaggerated thus leaving the students to solve the problems with some minor hints.

Appendix

VHDL Code

Code Snippet 6: Complete Transmitter Program

```
1 -----
2 ----- Description
3 -----
4 -- ADC (Analog voltage in, parallel byte out) with Shift Register serial output.
5
6 -- ADC based on SAR (Successive Approximation Register) with feedback through DAC and
7   ↳ subsequent comparator.
8 --
9 -- The SAR is a state machine that is initialised by a sample-pulse (clk_Ts) whereby it
10  ↳ sets the MSB of its parallel output HIGH and the rest LOW,
11 -- this is fed into the DAC which outputs an analog voltage corresponding to the input (ie.
12  ↳ "10000000" in -> Vmax/2 out),
13 -- this voltage is fed into the comparator and compared with the external input signal. If
14  ↳ it is higher than the input signal then the comparator's output is LOW, else HIGH.
15 -- The SAR then uses this information to set the MSB HIGH or LOW before moving onto Bit
16  ↳ n-1. State changes in the SAR are triggered by a bit-rate pulse (clk_Tb).
17
18 -----
19 -- Libraries
20 -----
21 library ieee;
22 use ieee.std_logic_1164.all;
23 use ieee.std_logic_unsigned.all;
24
25 -----
26 -- Entity
27 -----
28 entity Tx_FINAL is
29     port(  CLOCK_50      : in std_logic;      -- 50MHz internal clock.
30           reset         : in std_logic;      -- resets and/or initializes clocked elements.
31           ↳ Asynchronous.
32           D_async       : in std_logic;      -- input from external
33           ↳ (asynchronous) comparator.
34           Q              : buffer std_logic_vector(7 downto 0); -- parallel output from
35           ↳ SAR.
36           clk_Ts        : buffer std_logic;  -- Generated 'sample-rate'
37           ↳ clock.
38           clk_Tb        : buffer std_logic;  -- Generated 'bit-rate'
39           ↳ clock.
40           LEDR          : out std_logic_vector(7 downto 0); -- SAR output display on
41           ↳ LEDs.
42           serial        : out std_logic;     -- Serial data out.
43           ↳ EIA-232.
44 end entity;
```

```
38
39 -----
40 --Architecture
41 -----
42 architecture rtl of Tx_FINAL is
43 -----
44 -- Constants
45 -----
46     constant clk_Ts_CONST : integer := 2079; -- Clock-gen constants. Determines frequency.
47     constant clk_Ts_5perc_CONST : integer := 1975; -- 5% duty cycle on Ts.
48     constant clk_Tb_CONST : integer := 207;
49
50 -----
51 -- Signals
52 -----
53     type StateType is (U, IDLE, SAR7, SAR6, SAR5, SAR4, SAR3, SAR2, SAR1, SAR0, STOP); -- Enumerated
54     ↪ machine states. U used in simulation only.
55     signal state : StateType;
56
57     signal D_semisync : std_logic;
58     signal D : std_logic;
59
60     signal cnt_Ts : std_logic_vector(11 downto 0);
61     signal cnt_Tb : std_logic_vector(7 downto 0);
62
63     signal SR : std_logic_vector(8 downto 0); -- shift register containing 8 DATA
64     ↪ bits & 1 START bit. ((MSB -> LSB) & START).
65
66     -- STOP bits are shifted in, so
67     ↪ space need not be allocated
68     ↪ for them specifically.
69
70     signal SAR_result : std_logic_vector(7 downto 0); -- Holds the SAR output after a
71     ↪ completed conversion. Multiple processes use this result (at different times) and
72     ↪ so a separate signal is needed.
73
74     signal SR_start : std_logic; -- Has ADC completed at least once? Prevents SR
75     ↪ from outputting undefined values before first SAR conversion.
76
77 begin
78
79     -----
80     -- Architecture: - Top Level
81     -----
82
83     serial <= SR(0); -- Serial output from LSB of Shift Register (in accordance with
84     ↪ EIA-232).
85
86     -----
87     -- Process: proc_SAR
88     -- Description: SAR (successive approximation register) state machine.
89     -- State sequence: IDLE -> SAR7 -> ... -> SAR0 -> STOP -> IDLE0
90     -- Input(s) : CLOCK_50, clk_Tb, clk_Ts, reset, D
91     -- Output(s): Q, LEDR
92     -- Internal Signals: state, SAR_result, SR_start
93     -----
94
95     proc_SAR : process(CLOCK_50, reset)
96     begin
97         if reset='0' then -- CHECK WHETHER RESET IS INVERTED!
98             state <= IDLE;
99             LEDR <= (others => '0');
```

```
86     SAR_result <= (others => '1');
87     SR_start <= '0';
88
89     elsif rising_edge(CLOCK_50) then
90         if clk_Ts='1' then
91             Q <= "10000000";    -- MSB set, first approximation is half of maximum
92                                 ↳ value.
93             state <= SAR7;      -- Switch to next state in sequence.
94         elsif clk_Tb='1' then
95             case state is
96                 when SAR7 =>
97                     Q(7) <= D;    -- If V_DA approximation higher than sampled
98                                 ↳ signal, D is set LOW, and thus also Q(n).
99                     Q(6) <= '1'; -- Add 1/4 of maximum value to approximation, and
100                                ↳ so on for subsequent states.
101                     state <= SAR6;
102                 when SAR6 =>
103                     Q(6) <= D;
104                     Q(5) <= '1';
105                     state <= SAR5;
106                 when SAR5 =>
107                     Q(5) <= D;
108                     Q(4) <= '1';
109                     state <= SAR4;
110                 when SAR4 =>
111                     Q(4) <= D;
112                     Q(3) <= '1';
113                     state <= SAR3;
114                 when SAR3 =>
115                     Q(3) <= D;
116                     Q(2) <= '1';
117                     state <= SAR2;
118                 when SAR2 =>
119                     Q(2) <= D;
120                     Q(1) <= '1';
121                     state <= SAR1;
122                 when SAR1 =>
123                     Q(1) <= D;
124                     Q(0) <= '1';
125                     state <= SAR0;
126                 when SAR0 =>
127                     Q(0) <= D;
128                     state <= STOP;
129                 when STOP =>
130                     state <= IDLE; -- Loop back to IDLE state, until next Ts trigger.
131                                     ↳ LEDR <= Q;    -- Indicate conversion value.
132                                     ↳ SAR_result <= Q;
133                                     ↳ SR_start <= '1'; -- First digital conversion completed, shift
134                                     ↳ register now active.
135                 when IDLE | U =>
136                     -- do nothing
137             end case;
138         end if;
139     end if;
140 end process;
```

```
138 -----
139 -- Process: proc_comparator_read
140 -- Description: Makes the asynchronous comparator output (signal D) synchronous in
141   ↳ order to mitigate metastability issues.
142 -- Does this by synchronously reading D into an intermediate flip-flop,
143   ↳ 'D_semisync'.
144 -- Input(s) : D_async
145 -- Output(s): D
146 -- Internal Signals: D_semisync
147 -----
148 proc_comparator_read : process(CLOCK_50)
149 begin
150     if rising_edge(CLOCK_50) then
151         D_semisync <= D_async;
152         D <= D_semisync;
153     end if;
154 end process;
155
156 -----
157 -- Process: proc_Ts
158 -- Description: Generates the sample-rate clock, clk_Ts
159 -- Input(s) : CLOCK_50, reset
160 -- Output(s): clk_Ts
161 -- Internal Signals: cnt_Ts
162 -----
163 proc_Ts: process(CLOCK_50,reset) -- reset is asynchronous, and so process must be
164   ↳ sensitive to it!
165 begin
166     if reset='0' then -- CHECK IF LOGIC INVERTED!
167         cnt_Ts <= (others => '0'); --Clear counter and pull clock output low.
168         clk_Ts <= '0';
169     elsif rising_edge(CLOCK_50) then
170         if cnt_Ts = clk_Ts_5perc_CONST then
171             clk_Ts <= '1';
172             cnt_Ts <= cnt_Ts + 1;
173         elsif cnt_Ts = clk_Ts_CONST then
174             clk_Ts <= '0';
175             cnt_Ts <= (others => '0');
176         else
177             cnt_Ts <= cnt_Ts + 1;
178         end if;
179     end if;
180 end process;
181
182 -----
183 -- Process: proc_Tb
184 -- Description: Generates the bit-rate clock, clk_Tb
185 -- Input(s) : CLOCK_50, reset
186 -- Output(s): clk_Tb
187 -- Internal Signals: cnt_Tb,
188 -----
189 proc_Tb: process(CLOCK_50,reset)
190 begin
191     if reset='0' then -- CHECK IF LOGIC INVERTED!
192         cnt_Tb <= (others => '0'); --Clear counter and pull clock output low.
193         clk_Tb <= '0';
```

```
191     elsif rising_edge(CLOCK_50) then
192         if cnt_Tb = (clk_Tb_CONST - 1) then
193             clk_Tb <= '1';
194             cnt_Tb <= cnt_Tb + 1;
195         elsif cnt_Tb = clk_Tb_CONST then
196             clk_Tb <= '0';
197             cnt_Tb <= (others => '0');
198         else
199             cnt_Tb <= cnt_Tb + 1;
200         end if;
201     end if;
202 end process;
203
204 -----
205 -- Process: proc_shift_register
206 -- Description: Parallel in -> serial out, LSB first.
207 -- Input(s) : CLOCK_50, reset, Q, clk_Ts, clk_Tb
208 -- Output(s): serial
209 -- Internal Signals: SR, SAR_result, SR_start
210 -----
211 proc_shift_register: process(CLOCK_50, reset)
212 begin
213     if reset='0' then
214         SR <= (others => '1'); -- Init. SR with STOP bits.
215     elsif rising_edge(CLOCK_50) then
216         if SR_start='1' then -- Shift Register activated?
217             if clk_Ts='1' then
218                 SR <= SAR_result & '0'; -- Load Shift Register with DATA & START bit
219                 -- ((MSB..LSB) & START).
220             elsif clk_Tb='1' then
221                 SR <= '1' & SR(8 downto 1); -- Shift data right, Shift in STOP
222                 -- bit.
223             end if;
224         end if;
225     end if;
226 end process;
227 end architecture;
```

Code Snippet 7: Complete Receiver Program

```
1  ----- Description
   ↳ -----
2  -- RS-232 receiver.
3
4  -- Works at 12 kbaud.
5  -- Uses 'clock recovery' to synchronize timing. (Symbolsynkronisering)
6  -----
7
8  -----
9  -- Libraries
10 -----
11 library IEEE;
12 use IEEE.STD_LOGIC_1164.all;
13 use IEEE.STD_LOGIC_UNSIGNED.all;
14
15 -----
16 -- Entity
17 -----
18 entity Rx_FINAL is
19     port(    reset, CLOCK_50 : in std_logic;
20             serial_async : in std_logic; -- Serial in.
21             parallel : buffer std_logic_vector(7 downto 0);
22             LEDR : out std_logic_vector(7 downto 0);
23
24             DTx : out std_logic);
25 end entity;
26
27 -----
28 ----- Architecture
   ↳ -----
29
30 architecture arch of Rx_FINAL is
31     signal cnt : std_logic_vector(7 downto 0);
32     signal Q, next_Q : std_logic_vector(7 downto 0);
33     signal next_parallel : std_logic_vector(7 downto 0);
34     signal serial_semisync, serial : std_logic;
35
36     type stateType is (U,STOP,START,S0,S1,S2,S3,S4,S5,S6,S7);
37     signal state, next_state : stateType;
38 begin
39
40     LEDR <= parallel;
41     DTx <= serial;
42
43
44     ↳ -----
45     -- Process: proc_Rx_sync
46     -- Description: Synchronous part of serial->parallel Mealy machine.
47
48     -- Input(s) : reset, CLOCK_50, serial
49     -- Output(s): parallel
50     -- Internal Signals: cnt, state, next_state, next_parallel, Q, next_Q
```

```
50
↪ -----
51 proc_Rx_sync : process(CLOCK_50, reset)
52 begin
53     if reset='0' then
54         state <= STOP;
55         Q <= (others => '0');
56         cnt <= (others => '0');
57     elsif rising_edge(CLOCK_50) then
58         cnt <= cnt + 1;
59         if (state = STOP AND serial = '1') then
60             cnt <= (others => '0');
61
62             elsif cnt = 103 then
63                 state <= next_state;
64                 Q <= next_Q;
65                 parallel <= next_parallel;
66             elsif cnt = 207 then
67                 cnt <= (others => '0');
68             end if;
69         end if;
70     end process;
71
72 ↪ -----
73 -- Process: proc_Rx_comb
74 -- Description: Combinational part of serial->parallel Mealy machine.
75
76 -- Input(s) :
77 -- Output(s):
78 -- Internal Signals: state, next_state, next_parallel, Q, next_Q, serial, S(n)
79
80 ↪ -----
81 proc_Rx_comb : process(state, serial, Q)
82 begin
83     next_Q <= Q;
84     case state is
85     when STOP =>
86         next_state <= START;
87     when START =>
88         next_state <= S0;
89         next_Q(0) <= serial;
90     when S0 =>
91         next_state <= S1;
92         next_Q(1) <= serial;
93     when S1 =>
94         next_state <= S2;
95         next_Q(2) <= serial;
96     when S2 =>
97         next_state <= S3;
98         next_Q(3) <= serial;
99     when S3 =>
100         next_state <= S4;
101         next_Q(4) <= serial;
102     when S4 =>
103         next_state <= S5;
104         next_Q(5) <= serial;
```



```
103         when S5 =>
104             next_state <= S6;
105             next_Q(6) <= serial;
106         when S6 =>
107             next_state <= S7;
108             next_Q(7) <= serial;
109         when S7 =>
110             next_parallel <= Q;
111             if serial='0' then
112                 next_state <= S7;
113             else
114                 next_state <= STOP;
115             end if;
116         when others =>
117             -- undefined state
118             next_state <= STOP;
119     end case;
120 end process;
121 \newpage
122
123     ↩ -----
124     -- Process: proc_serial_read
125     -- Description: Makes the asynchronous input signal synchronous
126     --               in order to mitigate metastability issues.
127     --               Does this by synchronously reading the signal into
128     --               an intermediate flip-flop.
129
130     -- Input(s) : serial_async
131     -- Output(s): serial
132     -- Internal Signals: serial_semisync
133
134     ↩ -----
135     proc_serial_read : process(serial_async, CLOCK_50)
136     begin
137         if rising_edge(CLOCK_50) then
138             serial_semisync <= serial_async;
139             serial <= serial_semisync;
140         end if;
141     end process;
142 end architecture;
```

Schematics

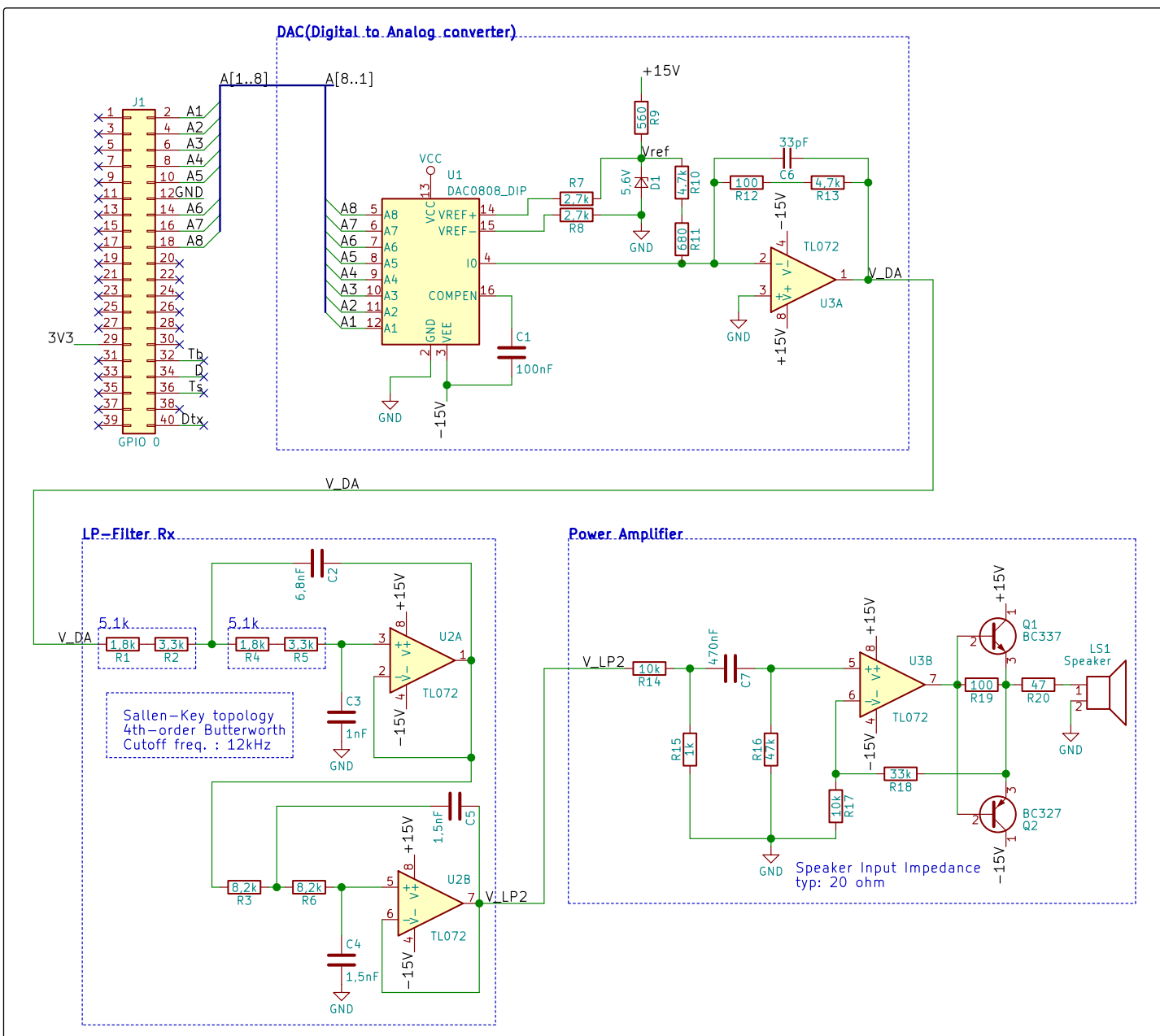


Figure 22: *Serial receiver*

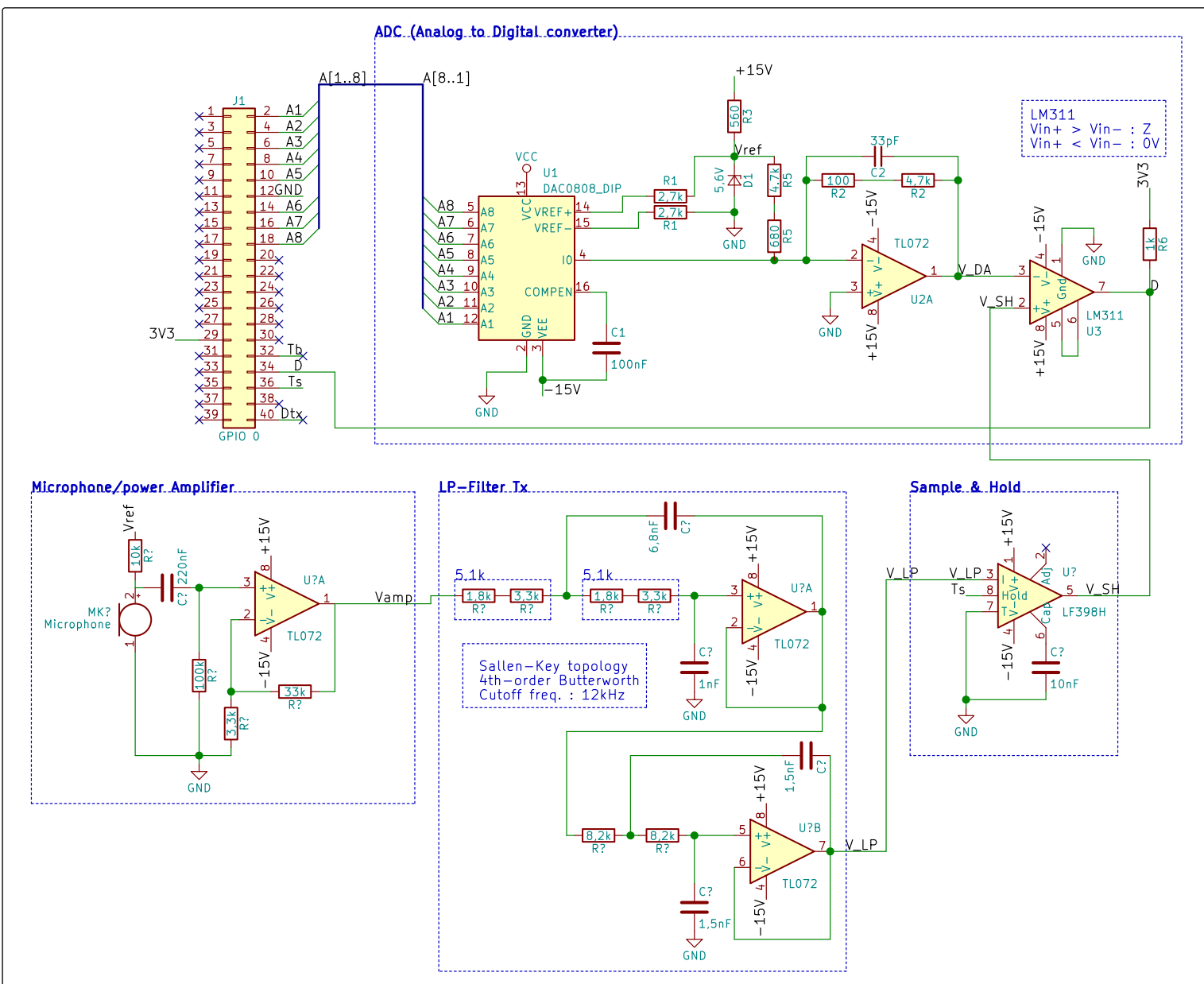


Figure 23: *Serial transmitter*